

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LEI ET AL.	
		Examiner Douglas M. Menz	Art Unit 2891	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,649,492	11-2003	Chu et al.	438/478
*	B	US-2004/0115916	06-2004	Lochtefeld et al.	438/597
	C	US-			
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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

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	N	JP 2002289533 A	10-2002	Japan	SAWANO et al.	H01L 21/205
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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